Applicant(s)/Patent Under Application/Control No. Reexamination 10/699,343 TAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 1774 Betelhem Shewareged **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2004/0065230 A1 04-2004 Katoh et al. 106/400 Α 428/32.26 US-2004/0037978 A1 02-2004 Tsubaki et al. В С US-D US-Ε US-F US-G US-US-US-1 US-J K US-Ļ US-М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Classification Name MM-YYYY Country Code-Number-Kind Code Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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